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Density and localized states' impact on amorphous carbon electron transport mechanisms

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This work discusses the electron transport mechanisms that we obtained as a function of the density of amorphous carbon (a-C) ultra-thin films. We calculated the density of states (total and projected), degree of electronic states' localization, and transmission function using the density functional theory and nonequilibrium Green's functions method. We generated 25 sample a-C structures using *ab-initio* molecular dynamics within the isothermal-isobaric ensemble. We identified three transport regimes as a function of the density, varying from semimetallic in low-density samples ($\leq 2.4 \text{ g/cm}^3$) to thermally activated in high-density ($\geq 2.9 \text{ g/cm}^3$) tetrahedral a-C. The middle-range densities ($2.4 \text{ g/cm}^3 \leq \rho \leq 2.9 \text{ g/cm}^3$) are characterized by resonant tunneling and hopping transport. Our findings offer a different perspective from the tight-binding model proposed by Katkov and Bhattacharyya [J. Appl. Phys. **113**, 183712 (2013)], and agree with experimental observations in low-dimensional carbon systems [see S. Bhattacharyya, Appl. Phys. Lett. **91**, 21 (2007)]. Identifying transport regimes is crucial to the process of understanding and applying a-C thin film in electronic devices and electrode coating in biosensors. Published by AIP Publishing. [<http://dx.doi.org/10.1063/1.4971010>]

I. INTRODUCTION

Amorphous carbon (a-C) is a noncrystalline solid allotropic form of carbon with a combination of sp^2 and sp^3 hybridized atoms. The ratio of bonds determines its density and different material classes and properties: from low-density sp^2 -rich non-graphitizing a-C, to high-density sp^3 -rich tetrahedral a-C (ta-C). The a-C thin films' electrical properties make them attractive for electronic devices and as electrode coating in electrochemical biosensors,^{1–5} as shown by their inclusion in the Emerging Research Devices chapter of the 2014 report, *International Technology Roadmap for Semiconductors*.⁶ For this reason, understanding and predicting electron transport mechanisms and electrical properties is vital to advance a-C-based technology.

Bhattacharyya⁷ explained different transport mechanisms from experimental measurements of a-C, correlating the conduction with the density of states (DOS) at the Fermi level (E_F). Some recent models^{8–10} attempted to describe the transport phenomena of a-C at the tight-binding level of theory, considering regions of concentrated sp^3 and sp^2 atoms as barriers and wells. These models need further refinement to include the random nature of the material's atomic structure, low-dimensionality, and coupling with electrodes in very thin films, because they affect the transport mechanisms in low-dimensional structures, as observed experimentally.^{1,11,12}

Although atomistic simulations have been used to model a-C, the lack of long-range order limits the system size

possible to simulate. Parametric and/or semi-empirical approaches have been proposed to overcome this limitation,¹³ but at the expense of calculated properties' accuracy. Atomistic *ab-initio* simulations based on density functional theory (DFT) remain the most accurate and affordable technique to calculate a-C properties from the electronic structure, for small- to medium-size systems.^{14,15} These simulations have focused on computational generation strategies, analysis of the atomic structure, and optical and mechanical properties.^{14–20} Combining DFT and nonequilibrium Green's functions (DFT-NEGF) has proven useful for qualitatively describing and investigating electron transport in nano and molecular systems, materials interfaces, and functional electronic devices and sensors.^{21–24} Despite the importance of the theoretical models established for electrical and transport properties,²⁵ to our knowledge, a-C transport properties have not been studied from first-principles calculations. Thus, here, we used DFT-NEGF to investigate the electron transport mechanisms in ultra-small a-C structures, analyzing the effects of density, dimensionality, and contact with metallic electrodes. We were able to explain different types of conduction observed experimentally:^{7,26,27} semimetallic in low-density a-C films, and thermally activated for sp^3 rich a-C. Our calculations also support experimental evidence of resonant tunneling (RT) in ultra-thin films,^{1,11,12} and establish three regimes of dominant mechanisms, as a function of the density.

Recent work¹⁹ demonstrated that the compressive pressure is an important variable to generate a-C structures. In their work, the authors obtained the desired pressure by

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readjusting the cell size followed by relaxation until reaching the target conditions. We propose a generalization of this generation strategy using Born-Oppenheimer Molecular Dynamics (MD) within the isothermal-isobaric ensemble (NPT). With this generation strategy, we can increase the sampling size for statistical purposes.

The computational results presented here are important in the context of predictive modeling and engineering of materials with specific electrical properties, especially when considering the materials' aimed industrial applications.

II. COMPUTATIONAL DETAILS AND METHODS

We carried out our calculations with the Kohn-Sham DFT method,²⁸ using the Perdew-Burke-Ernzerhof (PBE) generalized gradient approximation (GGA) for the exchange-correlation functional,²⁹ as implemented in the GPAW code.³⁰ GPAW is a grid-based implementation of the projector-augmented wave (PAW) method.³¹ Unless otherwise specified, the calculations used a plain waves (PW) basis set with the cut-off set to 400 eV for the a-C generation and a double- ζ polarized (DZP) linear combination of atomic orbitals (LCAO) basis set for the transport calculations, which yields good convergence for a-C systems.^{32,33} The k -space integration was done over a $(4 \times 4 \times 1)$ Monkhorst-Pack grid.³⁴ The atomic positions were optimized following the Broyden-Fletcher-Goldfarb-Shanno (BFGS) algorithm^{35–38} until all the forces acting on the atoms were below 0.05 eV/Å.

A. Bulk a-C generation method

We built 25 orthogonal supercells of 64 randomly positioned carbon atoms. The dimensions of each supercell in the xy plane are multiples of the diamond unit cell (111) plane ($5.8 \text{ Å} \times 5.0 \text{ Å}$), and the z component was adjusted so that the sum of the atoms' masses divided by the volume of the cell yielded a target density. After a full relaxation, the system was equilibrated at 300 K (± 10 K) using the Berendsen algorithm³⁹ within the canonical ensemble (NVT dynamics). After equilibration at 300 K, the temperature was kept constant using the Berendsen algorithm within the frame of isothermal-isobaric (NPT) dynamics, with a target compressive pressure, calculated from a linear fit of experimental data by Fallon *et al.*⁴⁰

$$P = 0.0718 * f_{sp^3} + 3. \quad (1)$$

Here P is the target compressive pressure in GPa, and f_{sp^3} is the system's sp^3 fraction, which was calculated from fitted experimental data by Ferrari *et al.*⁴¹

$$f_{sp^3} = 70.73 * \rho - 132.91, \quad (2)$$

where ρ is the target density of the sample in g/cm^3 .

The DOS and projected DOS (PDOS) of the sample used to analyze the electronic structure and determine a-C electronic properties are calculated by means of the converged Kohn-Sham eigenstates $|\psi_n\rangle$, with eigenvalue ε_n

$$g(E) = \sum_n \langle \psi_n | \psi_n \rangle \delta(E - \varepsilon_n), \quad (3)$$

$$g_{\alpha,i}(E) = \sum_n |\langle \phi_i^\alpha | \psi_n \rangle|^2 \delta(E - \varepsilon_n). \quad (4)$$

Here $g(E)$ is the DOS, E is the energy variable, $g_{\alpha,i}(E)$ is the PDOS, and $|\phi_i^\alpha\rangle$ is the i^{th} atomic orbital of atomic site α . To compensate for finite k -space sampling, the states are smeared with a Gaussian function centered at ε_n [$\delta(E - \varepsilon_n)$ in Equations (3) and (4)]. The width of the Gaussian function was set to 0.01 eV to better show the features in the electronic density of states. Note that the width of the Gaussian is smaller than the electronic smearing set to 0.1 eV in the calculations.

We defined the hybridization of an atom by counting the number of neighbors within a cutoff radius of 1.9 Å, considered the bonding distance: an sp^2 atom has three neighbors, while an sp^3 atom has four neighbors. This definition and cutoff radius have been used in the literature, obtained from the analysis of the radial distribution function.^{15–17,19,33,42} After labeling each atomic site, it is easy to qualitatively assess the contributions of sp^2 and sp^3 sites to the DOS by summing the contributions of all the sites in the system

$$g_{sp^2/sp^3}(E) = \sum_{\alpha=sp^2/sp^3} \sum_{i=2s,2p} g_{\alpha,i}(E), \quad (5)$$

where $g_{sp^2/sp^3}(E)$ is the contribution of sp^2 or sp^3 sites to the DOS.

Finally, we define the local DOS (LDOS) as the sum of $g_{\alpha,i}$ over the valence states i of all the sites α in a particular region in space.

B. Transport system

The generated a-C samples were used to build a system for electron transport calculations that consists of a scattering region and left and right electrodes. The scattering region was built with a molecule (a-C sample) and two principal layers (PL), which in our case are slabs of 3 fcc (111)Au atomic layers (a more extensive discussion on PL is found elsewhere^{43–47}). The Au/a-C interfaces in the scattering region were relaxed to prevent abrupt changes in the electrostatic potential. The interface was modeled with a reduced system consisting of an a-C slab, and built taking the atoms within a 5 Å surface measured from the topmost C atom. For the bottom atoms a similar slab was defined. The surface was passivated with hydrogen to compensate for dangling bonds.¹⁹ This slab and the PL were relaxed at six different distances from each other, between 1.5 and 3.5 Å, in a unit cell adding 10 Å vacuum up and down in the z direction to avoid orbital overlapping and periodicity effects. The atoms in the outermost 2 Å surface of the a-C slab and last atomic layer of the PL were fixed, so that the transport system could be reconstructed easily. Boundary conditions can cause an electrostatic potential gradient in the vacuum region (see the blue line in Fig. 1). The gradient creates an artificial electric field in the system, which may lead to nonphysical effects during the relaxation.⁴⁸ To ensure vacuum neutrality we set periodic boundary conditions in the x and y directions, and fixed boundary conditions with dipole correction in the z direction (see the red line in Fig. 1).

FIG. 1. The top panel shows the fully relaxed atomic structure at the Au/a-C interface. Yellow, gray, and white spheres represent Au, C, and H atoms, respectively. The bottom panel shows the electrostatic potential with (see the red solid line) and without (blue dotted line) dipole correction of a 3.2 g/cm³ sample. The Fermi level is shown as a dashed horizontal line.

The total energy of the six relaxed interfaces as a function of the Au/a-C distance was fixed to a quadratic polynomial. The minimum is assumed to be the optimum interface distance, which lies between 2.5 and 3 Å for all the generated samples, as Fig. 2 shows. The interfaces are finally relaxed using the calculated optimum distance shown in the top

FIG. 2. Normalized energy of the relaxed interfaces, calculated as a function of the Au/a-C distance for a 3.2 g/cm³ sample. We show the fixed quadratic curves and the equilibrium distance (dashed vertical lines).

panel of Fig. 1, and the scattering region is reconstructed and connected to the electrodes shown in Figs. 3(a) and 3(b).

The transport properties were calculated by means of the retarded Green's function,^{49,50} as implemented in the GPAW code⁴⁷

$$G^r(E) = [ES - H - \Sigma^r(E)]^{-1}, \quad (6)$$

where E is the energy variable, $\Sigma^r(E) = \sum_i \Sigma_i^r(E)$ is the sum of self-energies $\Sigma_i^r(E)$ (one for each electrode, in our case), and S and H are the overlap and Hamiltonian matrices of the scattering region, respectively (calculated self-consistently from the nonequilibrium electron density as detailed elsewhere⁴⁷). Using Equation (6), we can calculate the Transmission function as follows:

$$T(E) = \text{Tr}[\Gamma_1^r(E)G^r(E) \times \Gamma_2^r(E)G^r(E)^\dagger], \quad (7)$$

where $\Gamma_n^r(E) = i(\Sigma_n^r(E) - \Sigma_n^r(E)^\dagger)$ is the broadening matrix, the antihermitian part of the individual self-energies for each electrode. We can calculate the current as a function of energy, and therefore applied bias, by integrating Equation (7) in the Landauer Formula⁴⁹

$$I = \frac{q}{h} \int T(E)(f_1(E) - f_2(E))dE, \quad (8)$$

FIG. 3. (a) Atomic structure of low-density (2.29 g/cm³) and (b) high-density (3.20 g/cm³) systems used in quantum transport calculations. Yellow and gray spheres represent Au and C atoms, respectively.

where q is the electron charge, h the Planck's constant, and $f_n(E) = f(E - \mu_n)$ is the Fermi distribution function of electrode n . We used an electron smearing of $kT = 0.1$ eV and $\mu_n = E_F \pm qV/2$, with E_F being the equilibrium Fermi level of the Au electrodes, and V the applied voltage.

III. RESULTS AND DISCUSSION

A. Bulk a-C generation

Fig. 4(a) shows the results of ρ versus sp^3 for the generated a-C structures. The NPT method yields structures closer to the experiment,⁴¹ compared with other theoretical approaches, such as Carr-Parrinello molecular dynamics (CPMD) by Marks *et al.*¹⁷ The slope fitted for CPMD is $37.53 (\text{g/cm}^3)^{-1}$, while for our NPT calculation it is $58.51 (\text{g/cm}^3)^{-1}$. The slope fitted from experimental data⁴¹ is $70.23 (\text{g/cm}^3)^{-1}$ with 8.63% standard error. The absolute error for the calculated NPT slope, taking the experimental results as reference, is 16.67%, while for the CPMD it is 46.56%. A bigger set would yield better precision and confidence to the statistical measures, but it is out of the scope of this work.

FIG. 4. (a) Calculated sp^3 fraction as a function of the sample density (red dotted line). For comparison, we include experimental results from Fallon *et al.*⁴⁰ (black solid line), and computational CPMD results from Marks *et al.*¹⁶ (blue dashed line). (b) Pressure as a function of the sp^3 fraction (red dotted line). We also include experimental results from Fallon *et al.*⁴⁰ (black solid line).

Figure 4(b) shows the pressure as a function of the sp^3 fraction for the same points in Fig. 4(a). The error of the fitted slope with respect to experiment is 6.03%. Samples with a pressure closer to the experimental values, accurately predict sp^3 fraction as a function of ρ , and are therefore, used here for the electronic structure analysis and electron transport calculations.

B. Bulk a-C electronic structure

Amorphous semiconductors have a pseudogap, i.e., there are midgap states (traps) around the Fermi level. These are π states that lie between the σ gap¹³ and are localized due to the random potential around them (Anderson localization).⁵¹ The degree of electronic states' localization can be determined using a participation ratio analysis. This method was introduced by Tritsarlis *et al.* to the analysis of a-C structures,¹⁸ and it has the advantage of using the PDOS on each atom, instead of the single electron wave functions, which facilitates the localization calculation.⁵² The degree of localization $w(E)$ can be defined as follows:

$$w(E) = \sum_{\alpha=1}^N \frac{(N \times g_{\alpha}(E)/g'(E) - 1)^2}{N(N-1)}. \quad (9)$$

Here $g_{\alpha}(E) = \sum_{i=2s,2p} g_{\alpha,i}$ is the PDOS on site α , $g'(E) = \sum_{\alpha} g_{\alpha}(E)$ is the sum of all PDOS, and N is the number of atoms in the system ($N = 64$ atoms). For an extended state $g_{\alpha}(E) \rightarrow g'(E)/N$ and $w(E) \rightarrow 0$, while for a state strictly localized on atom α , $g_{\alpha}(E) = g'(E)$ and $w(E) = 1$.

In Fig. 5, we show the DOS and $w(E)$ for two of the samples with low (2.29 g/cm^3) and high (3.2 g/cm^3) densities. We see that $w(E)$ increases with density, as others reported in related work.¹⁹ For the low-density sample, a continuum of states exists around E_F delimited by two gaps around -1.11 and 1.86 eV (averaged from three samples, all with $\rho = 2.3 \text{ g/cm}^3$, approximately), while for the high-density sample, states around E_F are distinguishable from each other and the gaps are located around -1.91 and 1.80 eV (averaged from two samples with $\rho = 3.20 \text{ g/cm}^3$). There is also a small gap between the states around E_F that opens with density, but its particular value for each sample is distributed statistically, as the presence of the gap is not only determined exclusively by the amount of sp^3 , but also by the spatial correlation between sp^2 sites.¹³ This behavior is characteristic of a pseudogap where localized "defect" states are present within the optical gap.^{14,53}

Contributions due to sp^3 and sp^2 sites to the DOS and $w(E)$ are shown in Fig. 6 for a 3.20 g/cm^3 a-C sample. Most of the localized electronic states are contributed by the sp^2 sites, while the localization due to sp^3 sites is located mainly at the conduction band's edge, in good agreement with previous work.¹⁴ The PDOS for sp^2 sites is higher than for sp^3 sites within the pseudogap, which confirms that the localized electronic states that determine conduction are sp^2 -like. Because the sp^2/sp^3 fraction is directly related to the density, the latter will determine the transport mechanism of a-C.

Keeping in mind that π states around E_F , contributed by sp^2 sites,¹³ will determine the transport mechanism for low

FIG. 5. The top panel shows the total DOS and the bottom panel shows the degree of localization $w(E)$ of a-C samples with densities 2.29 (black dotted line) and 3.20 g/cm^3 (red solid line). The Fermi level's position is marked with a blue dashed line.

bias, and that these are highly localized, we fitted a weighted Lorentzian function to the $w(E)$ points within an energy window between -1.5 and 1.5 eV around E_F , in order to quantify localization parameters that help us determine different transport regimes as a function ρ and sp^3 (see Fig. 7)

$$w_{fit}(E) = A \frac{\Gamma}{(E - \varepsilon_0)^2 + \Gamma^2}. \quad (10)$$

Here, A is a fitting constant proportional to the peak magnitude of $w(E)$, Γ is a parameter, which determines the width over the

FIG. 6. PDOS (top) and degree of localization (bottom) of an a-C sample of density 3.20 g/cm^3 . The sum of the contributions of sp^2 and sp^3 sites, obtained with the PDOS on the individual atoms, are represented as red solid and blue dashed lines, respectively. The total DOS and degree of localization are plotted with black dotted lines. The midgap localized states are contributed mostly by sp^2 sites, while localized sp^3 sites are located mainly at the band edges

energy, and ε_0 determines the position of the peak, relative to the Fermi level. The magnitude of the peak of $w_{fit}(E)$, and its value at the Fermi level can then be calculated as $w_{fit}(\varepsilon_0) = A/\Gamma$ and $w_{fit}(E_F) = A\Gamma/(\varepsilon^2 + \Gamma^2)$ correspondingly.

In Fig. 8, we plotted both the $w_{fit}(\varepsilon_0)$ and $w_{fit}(E_F)$ as a function of the density and f_{sp^3} . Note that $w_{fit}(\varepsilon_0) \approx w_{fit}(E_F)$, which indicates that the sp^2 localized states' energies lie around E_F . The deviations from E_F can be explained by the fluctuations of our calculated points from the experimental ρ vs. f_{sp^3} curve. These are significantly higher for densities around 2.8 g/cm^3 , as Fig. 4(a) shows.

We approximated the trend of the data points to a Bezier polynomial. Three different trends can be differentiated with respect to the density and f_{sp^3} : (1) for low densities ($\rho \leq 2.55 \text{ g/cm}^3$) and $f_{sp^3} \leq 44.94$, the localization increases linearly; (2) for middle-range densities ($2.55 \text{ g/cm}^3 \leq \rho \leq 2.80 \text{ g/cm}^3$) and ($44.94 \leq f_{sp^3} \leq 59.64$), the localization is constant; (3) for high densities ($\rho \geq 2.80 \text{ g/cm}^3$) and $f_{sp^3} \geq 59.64$, the localization increments exponentially with respect to the density and f_{sp^3} . Essentially, we can expect these three regions, where the Fermi localization behaves differently to have different transport mechanisms. Next, we show how this is indeed the case.

C. Electron transport in a-C films

After contacting with the electrodes, the system loses periodicity in the transport direction (z). Furthermore, the relaxation at the interfaces with the metallic electrodes changes the atoms' positions and their bonding nature, becoming more sp^2 , similar to what happens at a-C surfaces.^{19,20} The variation in the atoms' positions changes the electronic structure of the sample, see Fig. 9. The new contacted system loses the electronic states gap for both high- and low-density samples and the electronic states' localization (calculated using the PDOS [see Equations (4) and (9)] on the carbon atoms within the scattering region) drops. The effect is stronger in samples with higher densities, in which localized sp^2 states are very confined in space due to the potential of dominant sp^3 sites. Confinement is lost when the interfaces reconfigure. We have shown that the high-density systems are shorter (in the z direction) than the low-density ones for a constant number of atoms. In the case of the highest density studied (3.2 g/cm^3), the length of the unit cell in the transport direction is $13.83 \text{ \AA}$, because we used $5 \text{ \AA}$ a-C slabs on each

FIG. 7. Degree of localization $w(E)$ and fitted Lorentzian function $w_{fit}(E)$ of a 2.29 g/cm^3 sample. The fitted function's peak and width are useful to analyze how the localization depends on the density.

FIG. 8. (a) Localization as a function of the density, and (b) localization as a function of the sp^3 fraction f_{sp^3} . The blue triangles are the peak values of the fitted localization $w_{fit}(\epsilon_0)$ and the blue dashed line is the fitted Bezier polynomial. The red circles are the value of the fitted localization at the Fermi level $w_{fit}(E_F)$ and the red solid line is the fitted Bezier polynomial. The localized states are located around E_F and three regimes of localization with ρ and f_{sp^3} can be distinguished.

side to build the interfaces, from which only 2 Å were fixed, 43% of the original bulk structure is free to reconfigure. This percentage, explains the drop on the localization peak, stronger for high density than for low-density samples.

Figure 10 shows the electron transmission function together with the PDOS on the sp^2 and sp^3 sites, providing qualitative information on the contribution of each hybridization to the available electronic states in the scattering region. PDOS has been widely used in the literature to analyze the transport properties of molecular junctions and nanoscale systems.^{21–24} However, the strategy of PDOS for transport analysis is subject to debate. PDOS changes depending on the chosen basis set and the subspace on which the Hamiltonian is diagonalized.⁵⁴ This is a challenge for the analysis of transport from the electronic structure.

We see that the shape of the transmission function follows the shape of the sp^3 PDOS for both low- and high-density samples, since it determines the pseudogap. However, the transmission function of the low-density sample contains resonances around the Fermi level, which are

FIG. 9. Bulk a-C DOS (black solid line), and the degree of localization $w(E)$ (black dashed line) on the secondary right axis. After contact with Au electrodes, the a-C thin film is created. Thin-film PDOS on C atoms (red dotted line) and the degree of localization (red dashed line) are also plotted. We show two a-C samples with $\rho = 2.29$ g/cm³ (top) and $\rho = 3.2$ g/cm³ (bottom), where the effect of dimensionality and contacts on the localization of high-density samples is notorious.

neither present in the sp^2 or the sp^3 PDOS. Resonances in the transmission function are usually associated to highly localized or quasi-bound (QB) states in the transport path. Such localized states lead to RT, which can be measured by changes in the I - V curve's slope and/or negative differential resistance.⁵⁵

RT transport is characteristic of composite materials and semiconductor heterostructures; it has been studied

FIG. 10. PDOS on sp^2 and sp^3 sites (blue dotted and red dashed lines, respectively), and the transmission function (black solid line) on the secondary right axis. Two a-C samples with $\rho = 2.46$ g/cm³ (top panel) and $\rho = 3.20$ g/cm³ (bottom panel) are shown. The low-density sample has a resonance around E_F , indicating that there are localized states at the same or close in energy, while the high-density sample shows a transmission gap around the Fermi level, indicating low electron density.

experimentally and theoretically.^{1,56–60} RT transport is calculated from the system's potential profile, which lets us calculate the localized states' energies. We divided the system into six slices along the transport direction and determined the available states and localization from the PDOS and $w(E)$ for each individual slice. We also calculated the density distribution along the transport directions and the contributions to the density due to sp^2 and sp^3 sites: ρ_{sp^2} and ρ_{sp^3} , respectively. To calculate ρ , ρ_{sp^2} , and ρ_{sp^3} along the transport direction, we divided the system here into 50 slices. The points were smoothed using a Bezier curve with the calculated points as the polynomial parameters. In Fig. 11 we plotted $w(E)$ and the density distribution for the same samples used in Fig. 10. These results show that the localization is directly related to the sp^3 distribution within the system. For the longer, low-density sample, a region exists between 10 Å and 12 Å where the sp^3 content rises, creating a potential barrier and causing the sp^2 electronic states to get localized, around 7 and 15 Å. We have only considered the features of ρ and $w(E)$ in one dimension, but it is worth mentioning that clusters of sp^2 sites might be distributed in 3D, influencing the transport mechanism. From Fig. 11(a) we see the similarity of the a-C with a square quantum well, which was the model proposed by Katkov and Bhattacharyya.⁸ However, their model considered symmetric wells with sharp barriers in the electrostatic potential (associated with sp^3 clusters), which is not the case for realistic disordered structures as the ones we present. The influence of this geometric asymmetries can be seen in the difference in the energy position of the QB states, their energy width, and localization degree. Although the localized states at each side of the barrier are not at the same energy (due to the wells' asymmetry), there is a considerable tail overlapping that is responsible for the resonance in $T(E)$, thus, evidencing RT transport as reported by Bhattacharyya *et al.*^{1,12}

Our results can also be contrasted with the experimental results from Protopopova *et al.*⁶¹ They studied the thickness dependence of the conductivity in a-C ultra-thin films, and proposed that for thinner films (≤ 4 nm) the conduction decreases due to the filling of exponentially distributed traps. On the contrary, we propose that conduction in high-density

FIG. 11. The top panel shows the degree of localization $w(E)$ in different spatial regions along the transport direction z . The bottom panel shows the density ρ (black solid line), and the sp^2 and sp^3 contributions to the total density ρ_{sp^2} (blue dotted) and ρ_{sp^3} (red dashed), respectively, averaged in the xy plane along the transport direction z . The system's average density is shown as a horizontal black dashed line for reference. Two systems are shown: (a) $\rho = 2.46$ g/cm³ and (b) $\rho = 3.20$ g/cm³.

ultra-thin films decreases due to the reduction in the number of charge traps (localized electronic states) induced by the atomic reconfiguration.

Computing $T(E)$ self-consistently using the DFT-NEGF method for each of the samples is a computationally expensive task. Moreover, to calculate the I - V curves with Equation (8), one has to compute $T(E)$ at each bias point. Therefore, we first calculated I - V characteristic curves using a reduced single- ζ polarized (SZP) basis set, as shown in Fig. 12. As the density of the sample increases, there is a change in the shape of the I - V characteristic curve. The I - V curve in Fig. 12(a) is similar to a linear response with minor slope changes. We attribute these changes to weakly localized states, but the dominant transport mechanism is semi-metallic through extended sp^2 $\pi - \pi^*$ states. On the other hand, in Fig. 12(b) we see notorious changes in the slope of the I - V curves, and for the case of the 2.67 g/cm³ sample, negative differential resistance around 1.3 and 1.7 V. This is evidence of RT and variable range hopping (VRH) transport, induced by strongly localized sp^2 states around E_F . Finally, in Fig. 12(c), we see linear characteristics for low biases. The slope changes as the voltage increases, which is a common feature in systems whose dominant transport mechanism is thermally activated.^{27,62}

These results are only qualitative, since a SZP basis set is unable to represent accurately the energetics of a-C, especially in high-density samples, as shown in previous works.^{32,33} Therefore, we calculated the I - V curves for a set of samples with densities ranging from 2.23 to 3.20 g/cm³, using a DZP basis set, as shown in Fig. 13. The I - V curve for the sample with $\rho = 2.46$ g/cm³, shows fluctuations in the slope, characteristic of RT transport, which is consistent with the localized states observed in Fig. 11(a), while the I - V characteristic for the sample with $\rho = 3.20$ g/cm³ is linear, for activated transport and consistent with the results in Fig. 13(b).

FIG. 12. Current-voltage (I - V) characteristic curves of a-C thin films with different densities, calculated using DFT-NEGF self-consistent method and a SZP basis set. We identify three types of conduction: (a) semimetallic for the low-density samples, (b) RT and VRH for middle-range densities and (c) activated for the high-density samples.

These transitions from one conduction mechanism to the other have been observed previously by Chimowa, Churochkin, and Bhattacharyya⁶³ for boron-doped nano-crystalline films. They showed that the transitions are heavily dependent on Nitrogen concentrations at low temperatures. However, the dominant conduction mechanism is also dependent on the temperature. They found that for concentrations of 10% to 15% Nitrogen, at temperatures below 118 K, the dominant conduction mechanism is VRH, while for concentrations of 20% Nitrogen, activated conduction was evidenced in the range of 28 K to 89 K. These conclusions are applicable to our findings, since the role of Nitrogen doping is to increase the level of disorder, i.e., to increase the fraction of sp^2 sites in the film. A more rigorous computational study of the temperature dependence of these transitions is needed to establish the range of temperatures in which our model is valid.

IV. CONCLUSIONS AND FUTURE WORK

Using an algorithm based on the underlying physical process modeled with NPT ensemble dynamics, we generated 25 bulk a-C samples, which were used to build ultra-thin film systems. This allowed us to study the transport's evolution, the localization as function of the sp^3 content, and density. We used Kohn-Sham DFT and the NEGF formalism to calculate the electron transmission and transport mechanisms. We identified three transport regimes, depending on the density. For very low densities ($\rho \leq 2.4 \text{ g/cm}^3$), the dominant transport mechanism is semimetallic. In high-density systems ($\rho \geq 2.9 \text{ g/cm}^3$), transport is driven by variable range and thermally activated hopping. For middle-range densities ($2.4 \text{ g/cm}^3 \leq \rho \leq 2.9 \text{ g/cm}^3$), RT and hopping (induced due to the appearance of localized states) dominate.

We demonstrated that contact with electrodes drops the localization of ultra-thin films' electronic states, affecting the electron transport mechanisms. The contacts' effect is

especially strong for high-density films, and our findings are in agreement with experimental works. These findings can impact materials engineering significantly, providing essential information for designing future sensors and devices envisioned by the electronics industry.

While we were able to differentiate between density regions, we have yet to establish sharp thresholds. This requires further calculations and adopting more sophisticated techniques to obtain a quantitative model. We must also take into account electron-phonon interactions and phase-incoherent processes (which have not been considered), to improve the description of electron transport in a-C films. A different approach needs to be taken, either by considering a mean-field approach, similar to the recent studies by McIntosh *et al.*⁶⁴ on superconductivity in boron-doped diamond, or by using the DFT-NEGF method, addressing electron-phonon interaction by means of perturbation theory at the level of self-consistent Born approximation.⁴⁶

SUPPLEMENTARY MATERIAL

See [supplementary material](#) for a more detailed view of the pseudogap and electronic gap and for more I - V characteristic curves of individual samples.

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FIG. 13. (I - V) curves calculated using a high-quality DZP basis set. The three types of conduction can be seen: (1) semimetallic for the low-density sample $\rho = 2.29 \text{ g/cm}^3$ (blue filled circles); (2) hopping and resonance tunneling for middle-range densities $\rho = 2.46$ and 2.90 g/cm^3 (red triangles and black squares); and (3) activated for the high-density sample $\rho = 3.20 \text{ g/cm}^3$ (magenta open circles).

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